

Notice of References Cited

Application/Control No.

10/567,701

Applicant(s)/Patent Under
Reexamination
CHEN ET AL.

Examiner

JAE Y. LEE

Art Unit

2419

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,915,325	07-2005	Lee et al.	709/202
*	B	US-6,845,100	01-2005	Rinne, Mika	370/395.43
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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